Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,985	TANIKAWA ET AL.	
Examiner	Art Unit	
John T. Kwan	2747	

SEARCHED					
Class	Subclass	Date	Examiner		
123	184.42	6/21/2005	JK		
	184.47				
	184.53				
	184.57				
	184.61				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
EXM	R				
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